Soft X-ray spectromicroscopy of polymers and biopolymer interfaces

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The status of soft X-ray spectromicroscopy (near edge X-ray absorption, or NEXAFS, microscopy) is summarized, with particular emphasis on recent collaborative studies carried out by the author’s group at the scanning transmission X-ray microscopy (STXM) and the photoelectron emission microscopy (PEEM) instruments at the Advanced Light Source. Results described include: characterization of phase segregation and filler particles in polyurethanes; effects of confinement on polymer self-organization; characterization of chemically structured polyurea capsule walls; and preferential interactions of proteins with chemically heterogeneous polymer surfaces. The latter is part of a systematic study of the biocompatibility of polymers used in blood contact applications.

Keywords: X-ray microscopy; X-ray absorption spectroscopy; polymers; phase segregation.

1. Introduction

Many natural and synthetic polymeric systems, such as engineered polymers, latexes, multilayers, biopolymers, etc., are heterogeneous. Soft X-ray spectromicroscopy (also known as near-edge X-ray absorption spectra, or NEXAFS, microscopy), in a number of variants, is finding increasing use in the analysis of these materials, on account of its ability to probe the chemical complexity of the constituents at a relevant spatial scale. This work briefly presents the main types of soft X-ray microscopy, comments on their relative strengths and weaknesses, and illustrates their performance with some examples from my current work. The versatility of the technique naturally leads to many collaborations. I recognize at the outset the essential contributions my collaborators and group members have made to the work presented here. Reviews of this field of science have been presented recently by Kirz et al. (1995), Ade (1998) and Ade & Urquhart (2000).

In NEXAFS microscopy, inner-shell electronic excitation is used as a chemically sensitive image-contrast mechanism. NEXAFS spectra can be acquired on a small region down to the spatial resolution limit of the instrument (‘microspectroscopy’), and images can be acquired at photon energies selected for their chemical sensitivity (‘analytical microscopy’). In many recent applications, the full power of the combined spatial–spectral domain is exploited by automated acquisition of image sequences, which produce a three-dimensional data set which can be analyzed to extract the maximum possible chemical information from the region studied (‘spectromicroscopy’). Two examples of this type of data, namely the sequence of X-ray micrographs used to map the components of a multi-component polyurethane and then to detect albumin against this polymer, have been deposited as a multimedia adjunct (.mpg file) to this paper.† Development of new efficient acquisition (Jacobsen et al., 2000) and data analysis procedures (Hitchcock, Koprinarow & Kneedler, 2000; Koprinarow, Hitchcock, McCrory & Childs, 2000; Osanna & Jacobsen, 2000) is a very active area of microscopy.

2. Experimental techniques

Two main variants exist: transmission microscopy, which averages over a column of absorption and thus is generally considered ‘bulk’ sensitive, and electron emission microscopy, which is generally considered ‘surface’ sensitive. In fact, because one must use very thin samples to achieve adequate transmission of soft X-rays, the surface region contributes significantly to the transmission-mode signal. An example of a surface study by a transmission instrument is given herein. Similarly, in some electron detection microscopes, particularly PEEM instruments where the high electric field extracts low-energy electrons which have a large escape depth, the technique can be applied effectively to problems which are more of bulk than surface nature (De Stasio et al., 2000). Almost all soft X-ray transmission microscopes use zone-plate optics, either in full-field conventional transmission X-ray microscopy (TXM) or in scanning transmission X-ray microscopy (STXM) configurations. The accuracy of the zone placement and the width of the outermost zone determines the spatial resolution achievable with these elements, which is about 40 nm in most existing instruments, although recently 25 nm zone plates have been reported (Denbeaux et al., 2000). Besides high spatial resolution, NEXAFS microscopy with good chemical sensitivity also requires good energy resolution. Thus a high-performance monochromated beamline is required. STXM instruments are presently only operated at undulator beamlines because of the requirement to illuminate the zone plate coherently. The brightness requirements for TXM instruments are less severe and such instruments are very successfully operated at bending-magnet sources.

Several instrument classes are available for electron emission-based X-ray microscopy. These include point-focus devices using zone plates (scanning photoelectron microscopy, SPEM) or reflection X-ray optics [e.g. MAXIMUM, described by Ng et al. (1994)], and electron imaging devices using electrostatic and/or magnetic electron magnification technologies, such as PEEM. Samples for SPEM or PEEM must be ultra-high-vacuum compatible and a modicum of conductivity is required, although insulating polymers can be studied in the form of uniform thin films, with typically less than 50 nm of insulating layer. In contrast, TXM and STXM instruments can be readily adapted to a wide range of environments, from vacuum to atmospheric pressure, to solution studies. When traditional transmission detection is employed, TXM and STXM signals are almost completely determined by the X-ray absorption coefficient. In contrast, the signal in PEEM (and to a lesser extent SPEM) is determined not only by X-ray absorption, but also by many other factors, i.e. topography, shadowing, work function and charging. As a consequence, it has been quite straightforward to develop analysis procedures which provide quantitative chemical analysis with STXM and TXM (Loo et al., 2000), but such analysis procedures are much less developed for PEEM or SPEM.

As will be clear in the following examples, we use the NEXAFS spectral information to the maximum extent to extract quantitative chemical results, either by spectral fitting of point spectra, or by ‘stack-fit’ (Hitchcock, Koprinarow & Kneedler, 2000) or singular value decomposition (SVD) (Koprinarow, Hitchcock, McCrory & Childs, 2000) procedures applied to full image sequences or line scans. These methodologies, along with many other useful image and spectral data processing procedures are available in the IDL-based package aXis2000, which is available from the author (consult http://unicorn.mcmaster.ca/aXis2000.html).

† Supplementary data for this paper are available from the IUCr electronic archives (Reference: HIS003). Services for accessing these data are described at the back of the journal.
Polyurethane polymers are formed from three major reagents: a diisocyanate (OCN-R-NCO), a polyol [HO-(R’-O)n-R’-OH] and water, in addition to lower concentrations of chain extenders, cross-linkers, surfactants and catalysts. R is typically aromatic [toluene diisocyanate (TDI) or methylenebis(phenyl isocyanate) (MDI)], while R’ is an aliphatic polyester [e.g. polypropylene oxide (PPO)].

The reaction of the isocyanate and the alcohol forms a urethane linkage. The reaction of two isocyanate groups with water forms a carbamoyl linkage. The reaction of two isocyanate groups with water forms a urea linkage. The reaction of an isocyanate group with a hydroxyl group forms a urethane group.

NEXAFS is readily able to distinguish urea and urethane linkages, to determine polyol content and to identify the types of R and R’ groups in a given polyurethane (Urquhart, Ade et al., 1999). Methods for quantitative spatially resolved mapping of the key functional groups (particularly urea and urethane) have been developed (Urquhart, Ade et al., 1999; Urquhart, Hitchcock et al., 1999). Comparison with compositions predicted from formulation chemistry indicates that NEXAFS can determine chemical content down to ~5 mol%, with 10–20% accuracy. This is a remarkably good level of quantitation given the relatively small spectral differences which are the basis for this quantitative chemical analysis (mainly a shift of ~0.4 eV between the urea and urethane πC=O signals around 290 eV), and the extensive overlap of these key features with broad underlying σ resonances of the dominant polymer. Good energy resolution (~0.1 eV) is essential. Fig. 1 illustrates this analysis applied to the determination of the relative urea and urethane content of matrix and precipitate regions of a macrophase segregated polyurethane (Rightor et al., 2000). As illustrated, it is possible to obtain quantitative analysis near the limits of the spatial resolution, which are ~45 nm at the National Synchrotron Light Source (NSLS) and ~90 nm at the Advanced Light Source (ALS) (current configuration). This analysis clearly determined that the precipitates are almost completely urea, with very little urethane. This is the first direct confirmation that precipitation in water-blown polyurethane foams is driven by water insolubility in the organic reaction mixture, which leads to urea-rich macrophase precipitates.

In order to make foams with higher hardness, copolymer polyols (CPPs), which are dispersions of a rigid polymer in polyether polyol, are added to the polyurethane (Gier et al., 1998). STXM is being used to help understand how CPP substances affect mechanical properties such as the elastic modulus.

3. Examples

3.1. Polyurethanes

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Patterning of thin polymer films is attracting increasing interest, both from a fundamental point of view and on account of potential technological applications. However, the thermal stability of these films can be a limitation on account of hole formation driven by dispersion forces which amplify structural instabilities at film–surface interfaces. Mechanical confinement of polymer films offers the possibility of control over this instability, which in turn raises possibilities for unique self-assemblies of polymers on surfaces patterned on submicrometre length scales.

In order to separate thin film–thin film interactions from thin film–substrate interactions, studies are being performed by the Dutcher group (Dalnoki-Varess et al., 1999) on free-standing trilayer structures, consisting of a thin layer of a low-melting rubbery polymer (polysoprene, PI) between two thin layers of a higher-melting rigid polymer (polystyrene, PS). Optical microscopy readily reveals fascinating patterns that form spontaneously or after gentle annealing of PS–PI–PS trilayers. A mechanism of formation involving long-range dispersion forces has been proposed (Dalnoki-Varess et al., 1999). However, the optical studies could not determine to what extent each layer contributes to the patterning through its spatial reorganization. Such information is required to evaluate the proposed model quantitatively. Quantitative mapping with STXM readily distinguishes the patterning in the PS layers from that in the PI layer. Fig. 3 illustrates quantitative composition maps for PS and PI derived from C 1 s STXM of two different PS–PI–PS trilayer films (Koprinarov, Hitchcock, Dalnoki-Varess et al., 2000). As expected, the softer polysoprene provides most of the patterning. However, significant patterning, which is out-of-phase with the PI pattern, is also measured in the polystyrene
layers. Surprisingly, the degree of this patterning was found to be larger in a sample annealed to a lower temperature (but more rapidly) than in a sample annealed more slowly to a higher temperature. This counter-intuitive result suggests that kinetics may be an important factor in controlling the pattern formation.

3.3. Microstructure of polyurea capsule walls

Polymers are frequently used to encapsulate other chemicals for a variety of purposes, e.g. packaging, transport, controlled release of drugs, nutrients, or pesticides, etc. We have used STXM to detect and quantify the chemical structure of walls, of sub-micrometre thickness, of polyurea capsules (Croll et al., 2000). The capsules are produced by interfacial polymerization: reaction between amine and isocyanate at the interface between organic and aqueous phases in a dispersion of a 1:10 mixture of MDI and xylene in an aqueous solution of ethylene diamine. In addition to the amine–isocyanate reaction which produces an asymmetric aromatic aliphatic urea, there is a competing reaction between the MDI and water which produces a symmetric di-aromatic urea. The temporal and spatial aspects of this competition can lead to the formation of gradients in the chemical structure of the walls of these capsules. These are postulated to occur as a result of (i) pre-reaction with water in an amine-free emulsification step, which results in an outer skin of symmetric urea; (ii) preferential diffusion and reaction of amine relative to water during the reaction, which leads to a central region rich in asymmetric urea; and (iii) post-synthesis curing when capsules are stored in water, in which water enters the capsule and reacts with residual isocyanate to form inner-wall structures rich in symmetric urea.

Fig. 4 shows images, chemical compositional maps and profiles of the structure of the capsule walls from two different polyurea capsule formulations. In one, a very short emulsification period was used and the outer skin of symmetric urea is relatively thin. In the other, emulsification was carried out for an extended 2 h period and a thicker outer skin of symmetric urea is found. The distributions of asymmetric (amine reaction) and symmetric (water reaction) ureas across these two membranes derived from C 1 s STXM image sequences are qualitatively consistent with the model of competitive reactions. Analysis of diffusion and reaction kinetics is now in progress to model quantitatively the capsule-wall formation process. The ability to fabricate structured walls with controlled chemical gradients could allow significant improvements in capsule properties for specific applications.

3.4. Protein–polymer interface studies

Increasingly, medicine uses artificial devices to replace or reinforce diseased body parts or to replace defective body functions. One
example is the use of devices made from synthetic polymers in hemodialysis. Activation of blood coagulation, thrombosis and the immune system are key problems here and in the many other situations where blood is in contact with artificial surfaces (heart–lung bypass for open-heart surgery, artificial heart valves, heart-assist devices, arterial grafts, intravascular stents, all involving thousands of patients daily worldwide). These effects are known to be initiated by interactions of blood proteins with the surface of the material, which is often a polymer. We are using NEXAFS microscopy to assist the group of John Brash (Chemical Engineering, McMaster) in efforts to develop polymer surfaces which prevent or minimize these phenomena. This motivates our thrust to develop effective X-ray spectromicroscopy tools to investigate protein–polymer interactions, ultimately at the solid–solution interface, but as an interim, in vacuum with PEEM, or in He atmosphere (STXM). There are significant challenges involved in this work, since the obvious surface analytical approach, electron yield detection, is often difficult or impossible with polymers on account of charging. For the past year we have been exploring the detection limits of both STXM and PEEM for a variety of proteins on a variety of polymer substrates. The polyurethane materials currently preferred for blood-contact applications have a microphase segregation that is on a sub-ten-micrometre scale, finer by a factor of 5–10 than the spatial resolution of existing soft X-ray spectromicroscopes. Thus we have been using a range of alternate materials: polyurethanes with macrophase segregation (as in Fig. 1) or with embedded filler particles (as in Fig. 2), as well as polystyrene–poly(methyl methacrylate) (pS–pMMA) blends. Our results to date indicate that even though STXM is essentially a ‘bulk’ technique, monolayer detection is possible although at the current sensitivity limits of this technique. In particular, the sensitivity to an adsorbed layer depends on the spectrum of the underlying polymer, since the most reliable detection scheme relies on use of the full spectral signature through image sequence analysis, rather than simply imaging at one specific wavelength.

Fig. 5 shows results of this approach for albumin adsorbed on a micromotred section of the two-filler polyurethane system presented in Fig. 2. The micromotred surface is believed to have the three classes of chemical constituents, namely polyether-rich matrix, SAN and PIPA, exposed at the surface. The protein was introduced by a true adsorption process from a very dilute buffered solution (0.1 mg ml$^{-1}$) with thorough rinsing. The amount detected is in the monolayer range in some regions (each albumin molecule is 3 × 8 nm) and there is clear indication of adsorption preference in the order PIPA > polyurethane matrix (polyether) > SAN (styrene–acrylonitrile). The sequence of STXM images that was used to derive the component maps presented in Fig. 5 is available as supplementary material (.mpg movie).

It is interesting to contrast the current capabilities of STXM and PEEM for studies of protein adsorption on polymers. Fig. 6 presents results of a PEEM study of albumin adsorption on a polytetramethylene oxide–ethylendiamine–MDI (PTMO–ED–MDI) polyurethane, used in blood-contact applications. The polymer was solvent cast to form a thin film on a silicon wafer coated with native oxide. Unfortunately, the resulting film was rather uneven, which generates large topographical contrast and probably means that the adsorption of the protein is driven by mechanical as well as chemical binding. Even so, the N 1 s NEXAFS readily distinguishes the loca-

Figure 5
Component maps derived from a C 1 s STXM image sequence of human serum albumin adsorbed on a polyurethane with PIPA and SAN filler particles (see Fig. 2 for further chemical microanalysis of the polymer substrate). The lower right-hand plot gives the mass thickness of each of the indicated components along the line indicated on the composition images. The color composite image (upper right) is a byte-scaled combination of the SAN (red), PIPA (green) and protein (blue) components, in order to display the spatial relationship of the protein relative to the two types of filler particles. (ALS BL 7.0 STXM instrument.)

Figure 6
Component maps derived from N 1 s PEEM image sequence of albumin adsorbed onto the surface of a polyurethane (PTMO–ED–MDI) solvent cast onto a silicon wafer. The plot compares spectra of the pure materials with spectra extracted from the region with highest signal strength of each component. (ALS BL 7.3 PEEM instrument.)
tion of the albumin on the polyurethane surface. The distribution of the protein appears to reflect avoidance of thicker regions of the polyurethane cast film. This could be caused simply by mechanical attachment in hollows on a rough polymer film, or it could reflect a preference of albumin to bind to the oxide surface of the bare silicon wafer. One of the limitations of the PEEM technique is that it is very difficult to quantify signal intensities since there are many factors other than the X-ray absorption coefficient that determine the sample response.

4. Future directions

NEXAFS spectromicroscopy is clearly a powerful analytical tool for chemical studies of sub-micrometre structure. Scanning zone-plate microscopy has special advantages for radiation-sensitive materials and for studies in the wet state. Significant improvements are just emerging or are expected in the coming few years. These include: cryomicroscopy, which is now available at several TXM facilities (ALS, BESYY) and at the NSLS STXM instrument (Maser et al., 2000; Wang et al., 2000); higher spatial resolution with improved zone plates (Denbeaux et al., 2000); phase-contrast (Miao et al., 1998) and dark-field (Chapman et al., 1996) detection techniques; in situ studies of mechanically, thermally and chemically perturbed materials; electron-yield surface detection in vacuum-operated STXM (Hitchcock et al., 1998); luminescence and X-ray fluorescence detection; new PEEM instruments with projected resolution below 5 nm.

In terms of science, continued improved performance will allow more detailed studies of blends, copolymers, self-assembly and nano-patterned polymer structures. It is widely expected that a new level of detail of polymer organization will be measurable when orientation-contrast studies (Smith & Ade, 1996) become much more routine with the introduction, in a few years, of STXM on beamlines attached to elliptically polarized undulators that can produce linearly polarized light with an arbitrary orientation.

Finally, a large portion of the polymer and biomaterials studies carried out to date have been performed by, or in collaboration with industrial researchers. The rapid recognition by industry of the remarkable value of this technique attests further to the added value NEXAFS microscopy provides to practical problem solving relative to other, more accessible, laboratory-based analytical microscopy techniques. The future of NEXAFS microscopy is bright!

This work is funded by the Natural Science and Engineering Research Council (Canada). The ALS STXM instrument was developed by T. Warwick (ALS), B. Tonner (UWM) and collaborators, with support from the US DOE under contract DE-AC03-76SF00098. Zone plates used at the ALS were provided by Eric Denbeaux et al., 2000; higher spatial resolution with improved zone plates (Denbeaux et al., 2000); phase-contrast (Miao et al., 1998) and dark-field (Chapman et al., 1996) detection techniques; in situ studies of mechanically, thermally and chemically perturbed materials; electron-yield surface detection in vacuum-operated STXM (Hitchcock et al., 1998); luminescence and X-ray fluorescence detection; new PEEM instruments with projected resolution below 5 nm.

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